MOSFET – Power, Single, N-Channel, SO-8 FL 30 V, 48 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Optimized for 5 V, 12 V Gate Drives
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

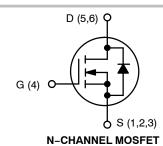
Parameter			Symbol	Value	Unit
Drain-to-Source Volt	Drain-to-Source Voltage			30	V
Gate-to-Source Volta	Gate-to-Source Voltage			±20	V
Continuous Drain		T _A = 25°C	I _D	16.7	Α
Current R _{θJA} (Note 1)		T _A = 100°C		10.5	
Power Dissipation R ₀ JA (Note 1)		T _A = 25°C	P _D	2.70	W
Continuous Drain		T _A = 25°C	I _D	25.2	Α
Current R _{θJA} ≤ 10 s (Note 1)		T _A = 100°C		15.9	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T _A = 25°C	P _D	6.16	W
Continuous Drain Current R _{BJA}	State	T _A = 25°C	Ι _D	9.7	Α
(Note 2)		T _A = 100°C		6.2	
Power Dissipation R _{θJA} (Note 2)		T _A = 25°C	P _D	0.92	W
Continuous Drain Current R _{BJC}		T _C = 25°C	I _D	48	Α
(Note 1)		T _C =100°C		30	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	P _D	23.2	W
Pulsed Drain Current	n $T_A = 25$ °C, $t_p = 10$ μs, $V_{GS} = 10$ V		I _{DM}	210	Α
Current Limited by Package T _A = 25°C			I _{Dmax}	100	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C
Source Current (Body	Source Current (Body Diode)			21	Α
Drain to Source DV/D	Drain to Source DV/DT			6.0	V/ns

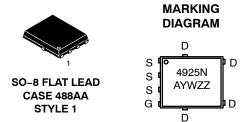


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
20.1/	5.6 mΩ @ 10 V	48 A
30 V	8.5 mΩ @ 4.5 V	40 A





A = Assembly Location Y = Year

W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4925NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4925NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 24 V, V_{GS} = 20 V, I_L = 26 A_{pk} , L = 0.1 mH, R_G = 25 Ω)	E _{AS}	34	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	ů

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface–mounted on FR4 board using the minimum recommended pad size.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	5.4	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.3	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	136.2	*C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	20.3	

- 3. Surface–mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 4. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V _{GS} = 0 V, I _{D(aval)} = 11.0 A, T _{case} = 25°C, t _{transient} = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.32	1.7	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	V _{GS} = 0 V, V _{DS} = 15 V			3.9		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	V _{GS} = 10 V I _D = 30 A		4.5	5.6	
			I _D = 15 A		4.5		0
		V _{GS} = 4.5 V	I _D = 30 A		6.8	8.5	mΩ
			I _D = 15 A		6.7		
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _E	₎ = 15 A		52		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			1264		
Output Capacitance	C _{OSS}				483		pF
Reverse Transfer Capacitance	C _{RSS}				143		
Capacitance Ratio	C _{RSS} / C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			0.113	0.226	

- 5. Pulse Test: pulse width \leq 300 $\mu s,$ duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
CHARGES, CAPACITANCES & GATE	RESISTANCE						
Total Gate Charge	$Q_{G(TOT)}$				10.8		20
Threshold Gate Charge	Q _{G(TH)}				2.0		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 6$	15 V; I _D = 30 A		3.8		nC
Gate-to-Drain Charge	Q_{GD}				4.2		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	15 V; I _D = 30 A		21.5		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(ON)}				9.5		
Rise Time	t _r	VG9 = 4.5 V. VD	s = 15 V.		32.7		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			16.4		ns
Fall Time	t _f				6.2		
Turn-On Delay Time	t _{d(ON)}	V _{GS} = 10 V, V _{DS} = 15 V,			7.4		_
Rise Time	t _r				27.5		
Turn-Off Delay Time	t _{d(OFF)}	I _D = 15 A, R _G	= 3.0 Ω		20.3		ns
Fall Time	t _f	1			4.1		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.86	1.1	\/
		I _S = 30 A	T _J = 125°C		0.75		V
Reverse Recovery Time	t _{RR}		•		25.8		
Charge Time	ta	$V_{GS} = 0 \text{ V, dIS/dt}$	= 100 A/μs,		12.4		ns
Discharge Time	t _b	$V_{GS} = 0 \text{ V, dIS/dt}$ $I_S = 30$	Α		13.4		
Reverse Recovery Charge	Q _{RR}	1			13.6		nC
PACKAGE PARASITIC VALUES			_				_
Source Inductance	L _S				1.00		nH
Drain Inductance	L _D	1	00		0.005		nH
Gate Inductance	L _G	T _A = 25°	U		1.84		nH
Gate Resistance	R_{G}	1			0.8	2.2	Ω

^{5.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

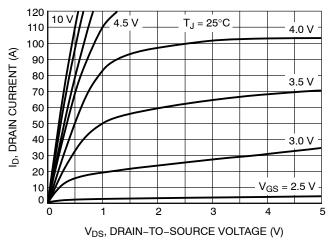
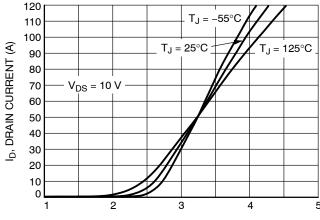


Figure 1. On-Region Characteristics



V_{GS}, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics

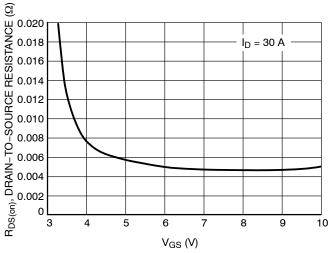


Figure 3. On-Resistance vs. V_{GS}

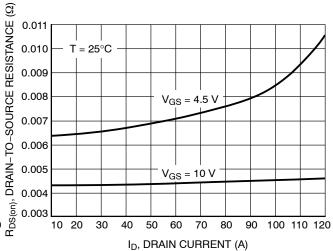


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

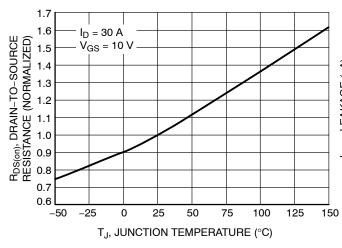


Figure 5. On-Resistance Variation with **Temperature**

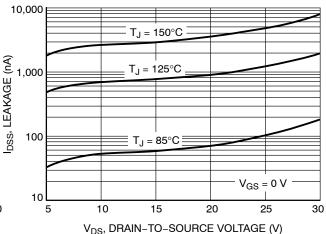


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

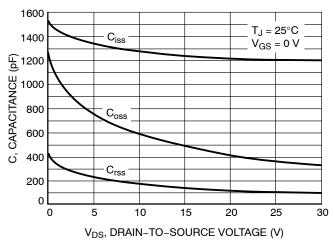


Figure 7. Capacitance Variation

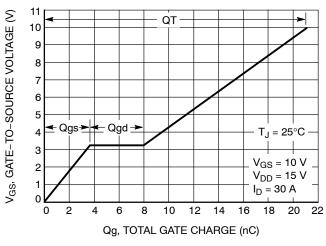


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

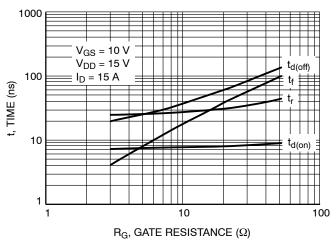


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

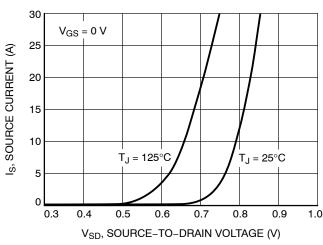


Figure 10. Diode Forward Voltage vs. Current

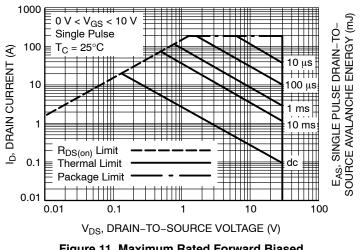


Figure 11. Maximum Rated Forward Biased Safe Operating Area

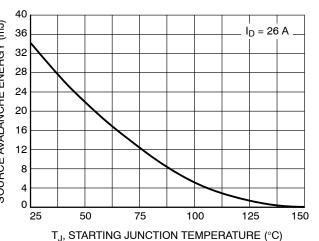


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

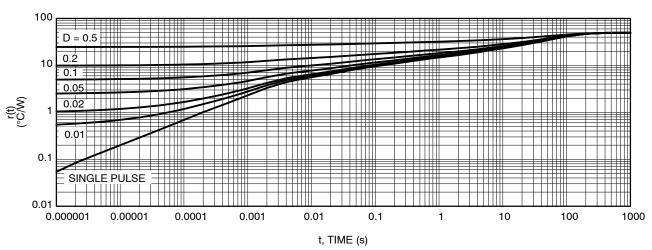


Figure 13. Thermal Response



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

BURRS

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	0.90	1.00	1.10			
A1	0.00		0.05			
b	0.33	0.41	0.51			
С	0.23	0.28	0.33			
D	5.00	5.15	5.30			
D1	4.70	4.90	5.10			
D2	3.80	4.00	4.20			
E	6.00	6.15	6.30			
E1	5.70	5.90	6.10			
E2	3.45	3.65	3.85			
е		1.27 BSC	;			
G	0.51	0.575	0.71			
K	1.20	1.35	1.50			
L	0.51	0.575	0.71			
L1	0.125 REF					
М	3.00	3.40	3.80			
A	0 0		12 °			

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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